## Notice of References Cited Application/Control No. 10/617,775 Examiner Michael A. Friedhofer Applicatit(s)/Patent Under Reexamination LIU ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
Х	Α	US-4,256,931	03-1981	Palisek, William F.	200/5A
X	В ;	US-5,584,380	12-1996	Naitou, Kiyotaka	200/315
X	C	US-6,153,840	11-2000	Dreher, Regine	200/301
Х	D	US-6,590,174	07-2003	Zysnarski et al.	200/310
X	Ε	US-6,635,831	10-2003	Kato, Mitsumasa	200/4
X	F	US-6,667,450	12-2003	Bulin et al.	200/302.3
X	G	US-6,771,992	08-2004	Tomura et al.	200/4
X	Н	US-6,797,896	09-2004	Lee, Ui-jin	200/6A
	ı	US-			
	J.	US-			
	К	US-			
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	•			,	
	0	·				
	Р					
	Q					
	R					
	s					
	Ţ					

## NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	v	
	w	
	x	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.